

## Shenzhen Toby Technology Co., Ltd.

Report No.: TB-EMC156393 Page: 1 of 27

## **EMC Test Report**

Application No.		TB170916934
Applicant	5	USC056
Equipment Under Tes	st (E	UT)
EUT Name		Power bank
Model(s)		SP8186, T1036
Brand Name		
Receipt Date	22	2017-09-25
Test Date		2017-09-25 to 2017-10-30
Issue Date		2017-10-30
Standards		EN55032: 2015 Class B EN55024: 2010+A1: 2015
Conclusions	5 :	PASS

In the configuration tested, the EUT complied with the standards specified above The EUT technically complies with the 2014/30/EU directive requirements

**Test/Witness Engineer** 

Approved & Authorized



This report details the results of the testing carried out on one sample. The results contained in this test report do not relate to other samples of the same product. The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in the report.

TB-RF-075-1.0



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## **1. General Information**

### 1.1. Client Information

:	USC056
-	China
	USC056
	China

### 1.2. General Description of EUT (Equipment Under Test)

EUT Name	:	Power bank
Model(s)	:	SP8186, T1036
Class of EUT	37	Class A 🛛 Class B
EUT Type	:	☐ Table top ☐ Floor standing ☐ combination
F <sub>x</sub>		≤108 MHz
Power Supply	:	Input: DC 5V/1500mA,Output: DC 5V/2100mA Capacity: 4400mAh
except for only c SP8186 only.	liffere	nodels are identical in schematic, structure and critical components ant appearance; therefore, EMC testing was performed with
F <sub>x</sub> : Highest inter	nal tr	equency.

## 1.3. Block Diagram Showing The Configuration of System Tested

Model	1

EUT		
<b></b>	EUT	EUT



Model 2

			11	
200	EUT	•	Full Load	
DRY				
- (				
39				
				_

#### 1.4. Description of Support Units

Name	Model	S/N	Manufacturer	Used "√"
Power Supply	02D050200		BSY	$\checkmark$

#### 1.5. Description of Operating Mode

To investigate the maximum EMI emission characteristics generated from EUT, the test system was pre-scanning tested based on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	Charging Mode
Mode 2	Discharging Mode

The EUT system operated these modes were found to be the worst case during the pre-scanning test as Following:

For EMI Test				
Final Test Mode		Description		
Mode 1	Charging Mode			
Mode 2	Discharging Mode			
	For EN	IS Test		
Final Test Mode	Descripti	on		
Mode 1	Charging Mode			
Mode 2	Discharging Mode			



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#### 1.6. Performance Criterion

**Criterion A:** The equipment shall continue to operate as intended without operator intervention. No degradation of performance of loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended.

**Criterion B:** After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended.

**Criterion C:** Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions.

#### 1.7. Measurement Uncertainty

The reported uncertainty of measurement y  $\pm$  U, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95 %.

Test	Parameters	Expanded Uncertainty (U <sub>Lab</sub> )	Expanded Uncertainty (U <sub>Cispr</sub> )
Conducted Emission	Level Accuracy: 9kHz~150kHz 150kHz to 30MHz	$\pm$ 3.42 dB $\pm$ 3.42 dB	$\pm$ 4.0 dB $\pm$ 3.6 dB
Radiated Emission	Level Accuracy: 9kHz to 30 MHz	±4.60 dB	N/A
Radiated Emission	Level Accuracy: 30MHz to 1000 MHz	±4.40 dB	$\pm$ 5.2 dB
Radiated Emission	Level Accuracy: Above 1000MHz	±4.20 dB	N/A
Mains Harmonic	Voltage	±3.11%	N/A
Voltage Fluctuations & Flicker	Voltage	±3.25%	N/A



#### 1.8. Test Facility

The testing report were performed by the Shenzhen Toby Technology Co., Ltd., in their facilities located at 1A/F., Bldg.6, Yusheng Industrial Zone, The National Road No.107 Xixiang Section 467, Xixiang, Bao'an, Shenzhen, Guangdong, China. At the time of testing, the following bodies accredited the Laboratory:

#### CNAS (L5813)

The Laboratory has been accredited by CNAS to ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories for the competence in the field of testing. And the Registration No.: CNAS L5813.

#### FCC List No.: (811562)

The Laboratory is listed in the United States of American Federal Communications Commission (FCC), and the registration number is 811562.

#### IC Registration No.: (11950A-1)

The Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing. The site registration: Site# 11950A-1.



## 2. TEST Results Summary

EMISSION				
Standards	Results			
EN 55032: 2015 Class B	N/A			
EN 55032: 2015 Class B	Pass(2)			
EN 61000-3-2: 2014	N/A			
EN 61000-3-3: 2013	N/A			
	Standards   EN 55032: 2015 Class B   EN 55032: 2015 Class B   EN 61000-3-2: 2014			

#### IMMUNITY

Description of test items	Standards	Results
Electrostatic Discharge (ESD)	EN 61000-4-2: 2009	Pass
Radio-frequency, Continuous radiated disturbance	EN 61000-4-3: 2006+A1:2008 +A2:2010	Pass
EFT/B Immunity	EN 61000-4-4: 2012	N/A
Surge Immunity	EN 61000-4-5: 2014	N/A
Conducted RF Immunity	EN 61000-4-6: 2014	N/A
Power frequency magnetic field	EN 61000-4-8: 2010	N/A(3)
Voltage dips, >95% reduction	and the second	
Voltage dips, 30% reduction	EN 61000-4-11: 2004	N/A
Voltage interruptions		
Note: N/A is an abbroviation for Not Apr		

**Note:** N/A is an abbreviation for Not Applicable.

- (1) For Harmonic Current the equipment power is less than 75W.
- (2) The EUT maximum operating frequency is less than 108MHz, so no requirement for the radiated disturbance for above 1GHz.
- (3) Not applicable, the EUT has not magnetic field.

# 3. Test Equipment Used Radiation Emission Test

Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date	
Spectrum Analyzer	Agilent	E4407B	MY45106456	Jul. 20, 2017	Jul. 19, 2018	
EMI Test Receiver	Rohde & Schwarz	ESCI 100010/007 Jul. 20, 2017		ESCI 100010/007 Jui		Jul. 19, 2018
Bilog Antenna	ETS-LINDGREN	3142E	00117537	Mar. 25, 2017	Mar. 24, 2018	
Bilog Antenna	ETS-LINDGREN	3142E	00117542	Mar. 25, 2017	Mar. 24, 2018	
Horn Antenna	ETS-LINDGREN	3117	00143207	Mar. 24, 2017	Mar. 23, 2018	
Horn Antenna	ETS-LINDGREN	3117	00143209	Mar. 24, 2017	Mar. 23, 2018	
Pre-amplifier	HP	11909A	185903	Mar. 24, 2017	Mar. 23, 2018	
Pre-amplifier	HP	8449B	3008A00849	Mar. 25, 2017	Mar. 24, 2018	
Cable	HUBER+SUHNER	100	SUCOFLEX	Mar. 24, 2017	Mar. 23, 2018	
Positioning Controller	ETS-LINDGREN	2090	N/A	N/A	N/A	
Discharge I	mmunity Test	-				
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date	
ESD Generator	HAFELY	PESD 1610	H808671	Mar. 27, 2017	Mar. 26, 2018	
Radiated Im	munity Test	-	-	-	-	
Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date	
Signal Generator	Rohde & Schwarz	SMT03	200754	Mar. 24, 2017	Mar. 23, 2018	
Power Meter	Rohde & Schwarz	NRVD	110562	Feb. 14, 2017	Feb. 13, 2018	
Voltage Probe	Rohde & Schwarz	URV5-Z2	12056	Feb. 14, 2017	Feb. 13, 2018	
Voltage Probe	Rohde & Schwarz	URV5-Z2	12074	Feb. 14, 2017	Feb. 13, 2018	
RF Amplifier	AR	50S1G4A	326720	Feb. 14, 2017	Feb. 13, 2018	
Bilog Antenna	ETS	3142C	00047662	Feb. 14, 2017	Feb. 13, 2018	
Horn Antenna	ARA	DRG-118A	16554	Feb. 14, 2017	Feb. 13, 2018	
Audio Analyzer	Rohde & Schwarz	UPL 16	SB2208	Feb. 14, 2017	Feb. 13, 2018	
Sound Level Calibrator	B&K	4231	264516	Feb. 14, 2017	Feb. 13, 2018	



## 4. Radiated Emission Test

- 4.1. Test Standard and Limit
- 4.1.1. Test Standard
  - EN 55032: 2015 Class B
- 4.1.2. Test Limit Bellow 1GHz

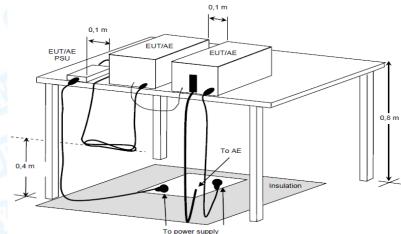
	Limit (dBµ\	//m) (3m)		
Frequency	Quasi-peak Level			
	Class A	Class B		
30MHz~230MHz	50	40		
230MHz~1000MHz	57	47		
Remark: 1. The lower limit shall apply at t 2. The test distance is 3m.	he transition frequency.			

#### Above 1GHz

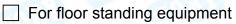
		Limit (dBµV/m	ı) (3m)	
Frequency (GHz)	Clas	s A	Class B	
(011-)	Peak	Average	Peak	Average
1~3	76	56	70	50
3~6	80	60	74	54

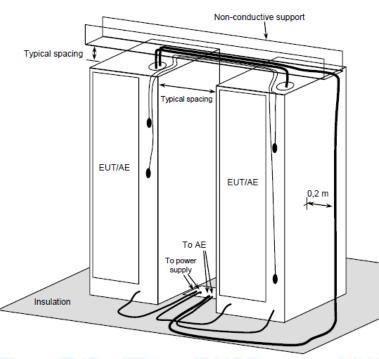
#### 4.2. Test Setup

For table top equipment

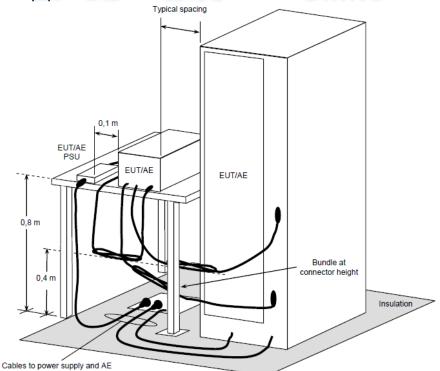








For combination equipment





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#### 4.3. Test Procedure

Measurement was performed according to clause 7.3 of CISPR 16-2-3.

The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m. The table was rotated 360 degrees to determine the position of the highest radiation. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.

The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range.

If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.

Highest internal frequency (Fx)	Highest measured frequency for radiated measurement	Measured Bandwidth
Fx ≤ 108 MHz	1 GHz	120kHz
108 MHz < Fx ≤ 500 MHz	2 GHz	1MHz
500 MHz < Fx ≤ 1 GHz	5 GHz	1MHz
Fx > 1 GHz	5*Fx up to a maximum of 6 GHz	1MHz
NOTE 1: For EM and TV broadcast rece	ivers Ex is determined from the highest freque	ency generated orused

**NOTE 1:** For FM and TV broadcast receivers, Fx is determined from the highest frequency generated orused excluding the local oscillator and tuned frequencies. **NOTE 2:** For outdoor units of home satellEquipment receiving systems highest measured frequency shall be 18GHz.

#### 4.4. Test Data

Please refer to the following pages.



#### **Bellow 1GHz**

EUT:	Powe	r bank	M	odel Name :		SP8186		
Temperature:	<b>25</b> ℃		R	Relative Humidity:		: 55%		
Test Voltage:	DC 5V		-01	2	1	000		2
Ant. Pol.	Horizontal				100			
Test Mode:	Mode 1							
Remark:					660	1323	~	
30		1 23 × × ×	4 56 26 20 20 20 20 20 20 20 20 20 20 20 20 20	Annow with the providence of the second seco	EN55032-C	ClassB-3M Rac Mai	diation rgin -6 dB	
and the second s			·			keelsen wikeel		
	60 70	80	(MHz)	300	400	500 600	700 1	000.0
20 30.000 40 50		80 Reading Level	(MHz) Correct Factor		400 Limit	500 600 OVe		000.0
20 30.000 40 50 No. Mk. F	60 70	Reading	Correct	300 Measure-		Ove	er	000.0
20 30.000 40 50 No. Mk. F	60 70	Reading Level	Correct Factor	300 Measure- ment	Limit	Ove m dB	er Det	
20 30.000 40 50 No. Mk. F 1 99.	60 70 Freq. MHz	Reading Level dBuV	Correct Factor dB/m	300 Measure- ment dBuV/m	Limit dBuV/r	Ove m dB 0 -8.8	er Def 35 p	tecto
20 30.000 40 50 No. Mk. F 1 99. 2 109	60 70 Freq. MHz 1797	Reading Level dBuV 52.59	Correct Factor dB/m -21.44	300 Measure- ment dBuV/m 31.15	Limit dBuV/r 40.00	Ove m dB 0 -8.8 0 -7.5	er Det 35 p 53 p	tecto eak
20 30.000 40 50 No. Mk. F 1 99. 2 109 3 115	60 70 Freq. MHz 1797 .0286	Reading Level dBuV 52.59 53.88	Correct Factor dB/m -21.44 -21.41	300 Measure- ment dBuV/m 31.15 32.47	Limit dBuV/r 40.00	Ove m dB 0 -8.8 0 -7.5 0 -8.6	er Det 35 p 53 p 61 p	tecto eak eak eak
20 30.000 40 50 No. Mk. F 1 99. 2 109 3 115 4 * 145	60 70 Freq. MHz 1797 .0286 .7256	Reading Level dBu∨ 52.59 53.88 53.17	Correct Factor dB/m -21.44 -21.41 -21.78	300 Measure- ment dBuV/m 31.15 32.47 31.39	Limit dBuV/r 40.00 40.00	Ove m dB 0 -8.8 0 -7.5 0 -8.6 0 -6.5	er 35 p 53 p 51 p 52 p	tecto eak eak

TB-RF-075-1.0

EUT:	Power bank			lodel Name :	S	SP8186	2115	
Temperatur	re: 25	5°C	R	Relative Humidity:		55%		
Test Voltag	e: D	C 5V	100	N. S.	ER!	192	-	
Ant. Pol.	V	ertical	2 199				182	
Test Mode:	М	ode 1		E.C.				
Remark:			1		Gal'	2	2	
30	2 3			*		sB-3M Radiation Margin -6	dB	
Ann	Mar Mir All	Maria M	y v mar	- Mary	what the whole	Mr. Hule and have a series of the series of		
20 30.000 40	50 60	70 80	(MHz)	300		My/h.L. 240,400 mm <sup>4</sup>	1000.000	
	50 60			300			1000.000	
		Reading					1000.000	
30.000 40		Reading	g Correct	300 Measure-	400 5	00 600 700 Over	1000.000	
30.000 40	Freq.	Reading Level dBuV	g Correct Factor	300 Measure- ment	400 5 Limit	00 600 700 Over	Detecto	
30.000 40 No. Mk.	Freq.	Reading Level dBuV 1 40.55	g Correct Factor dB/m	300 Measure- ment dBuV/m	400 5 Limit dBuV/m	00 600 700 Over dB	Detecto peak	
30.000 40 No. Mk.	Freq. MHz 32.979	Reading Level dBuV 1 40.55 9 49.63	g Correct Factor dB/m -15.67 -22.86	300 Measure- ment dBuV/m 24.88	400 5 Limit dBuV/m 40.00	00 600 700 Over dB -15.12 -13.23	Detecto peak peak	
30.000 40 No. Mk. 1 2 3	Freq. MHz 32.979 47.1599 53.1313	Reading Level dBuV 1 40.55 9 49.63 3 52.03	g Correct Factor dB/m -15.67 -22.86 -24.07	300 Measure- ment dBuV/m 24.88 26.77 27.96	400 5 Limit dBuV/m 40.00 40.00	00 600 700 Over dB -15.12 -13.23 -12.04	Detecto peak peak peak	
30.000 40 No. Mk. 1 2 3 4	Freq. MHz 32.979 47.1599 53.1313 133.618	Reading Level dBuV 1 40.55 9 49.63 3 52.03 8 50.23	g Correct Factor dB/m -15.67 -22.86 -24.07 -21.05	300 Measure- ment dBuV/m 24.88 26.77 27.96 29.18	400 5 Limit dBuV/m 40.00 40.00 40.00	00 600 700 Over dB -15.12 -13.23 -12.04 -10.82	Detecto peak peak peak	
No. Mk.	Freq. MHz 32.979 47.1599 53.1313	Reading Level dBuV 1 40.55 9 49.63 3 52.03 3 52.03 8 50.23 6 51.65	g Correct Factor dB/m -15.67 -22.86 -24.07 -21.05 -20.85	300 Measure- ment dBuV/m 24.88 26.77 27.96	400 5 Limit dBuV/m 40.00 40.00	00 600 700 Over dB -15.12 -13.23 -12.04 -10.82 -9.20	Detecto peak peak	

Emission Level= Read Level+ Correct Factor

EUT:			Dou	vor ho	nk	B	ladal Nama		en	106		-	5
-			Power bank 25 ℃				Iodel Name			3186	- 14		
	erature:		DC 5V			R	elative Hu	midity:	55%	6			
	oltage:						10		1		_	-	2
Ant. P	-		Horizontal Mode 2						1				
Test N									2				
80.0 df	r <b>k:</b> Bu∀/m							5.14				~	
30			1 1 1			2	3 X 5	EN55032	ClassB	Mar 6	gin -6	6 dB	utra .
Das depert	and the second second	shall W	-v(	scheneren	eografian/M	y		""/h////""					
-20	40	50	60 7	70 80	eege-tele-j <sup>hr</sup> e	(MHz)	3	00 <b>4</b> 00	500	600	700	10	00.0
30.000	40	50 Fre		70 80 Rea	adin <u>(</u>		Measure ment			600 Ove		10	00.0
30.000			q.	70 80 Rea	ading	g Correct	Measure	-	t			10 Dete	
30.000	Mk.	Fre	z	70 80 Rea Le	ading	g Correct Factor	Measure ment	- Limi	t //m	Ove	r		ecto
30.000 No.	Mk. 6	Fre MH:	eq. z 691	70 80 Rea Le	ading evel BuV	g Correct Factor dB/m	Measure ment dBuV/m	- Limi dBu∨	t //m 00	Ove dB	r 30	Dete	ecto eak
30.000 No.	Mk. 6 * 10	Fre MH: 50.06	eq. z 591 742	70 80 Rea Le dl 45 57	ading evel BuV 5.68	g Correct Factor dB/m -23.98	Measure ment dBuV/m 21.70	- Limi dBuv 40.0	t //m )0	Ove dB -18.3	r 30	Dete	ecto eak
No.	Mk. 6 * 10	Fre MH: 60.06	eq. z 591 742 856	70 80 Rea Le dl 45 57 50	ading evel BuV 5.68 7.42	g Correct Factor dB/m -23.98 -20.62 -19.73	Measure ment dBuV/m 21.70 36.80	- Limi dBuV 40.0	t //m 00 00	Ove dB -18.3	r 30 0 3	Dete pe pe	ecto eak eak
30.000 No. 1 2 3	Mk. 6 * 10 19 23	Fre MH: 60.06 61.47 99.98	eq. 2 991 742 856 985	70 80 Rea dl 45 57 50 45	ading evel BuV 5.68 7.42 0.90	g Correct Factor dB/m -23.98 -20.62 -19.73 -18.50	Measure ment dBuV/m 21.70 36.80 31.17	- Limi dBuV 40.0 40.0	t //m )0 )0 )0 )0	Ove dB -18.3 -3.2 -8.8	r 30 0 3 05	Dete pe	ecto eak eak eak

Emission Level= Read Level+ Correct Factor

25 ℃ DC 5V Vertical Mode 2
Vertical Mode 2
Mode 2
<u> (////////////////////////////////////</u>
and an have been and a second and the
0 60 70 80
Reading Freq. Level
MHz dBuV
8.8185 41.82
.2662 39.17
3.7550 48.77
0 0985 38 37
0.0985 38.37 0.3748 37.77



## 5. Electrostatic Discharge Immunity Test

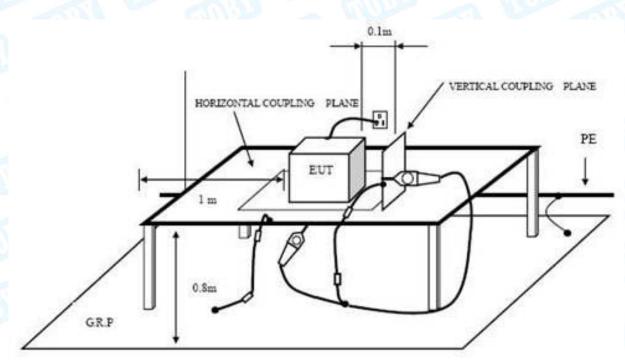
- 5.1. Test Requirements
- 5.1.1. Test Standard

EN 55024:2010+A1: 2015 (EN 61000-4-2:2009)

5.1.2. Test Level

Level	Test Voltage Contact Discharge (kV)	Test Voltage Air Discharge (kV)
1	±2	±2
2	±4	±4
3	±6	±8
4	±8	±15
Х	Special	Special

- 5.1.3. Performance criterion: B
- 5.2. Test Setup



INDIRECT DISCHARGE SETUP



#### 5.3. Test Procedure

#### 5.3.1. Air Discharge:

This test is done on a non-conductive surface. The round discharge tip of the discharge electrode shall be approached as fast as possible to touch the EUT. After each discharge, the discharge electrode shall be removed from the EUT. The generator is then re-triggered for a new single discharge and repeated 10 times for each pre-selected test point. This procedure shall be repeated until all the air discharge completed.

#### 5.3.2. Contact Discharge:

All the procedure shall be same as air discharge. Except that the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.

#### 5.3.3. Indirect discharge for horizontal coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied at the front edge of each HCP opposite the center point of each unit (if applicable) of the EUT and 0.1m from the front of the EUT. The long axis of the discharge electrode shall be in the plane of the HCP and perpendicular to its front edge during the discharge.

#### 5.3.4. Indirect discharge for vertical coupling plane

At least 10 single discharges (in the most sensitive polarity) shall be applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5m X 0.5m, is placed parallel to, and positioned at a distance of 0.1m from the EUT. Discharges shall be applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.

#### 5.4. Test Data

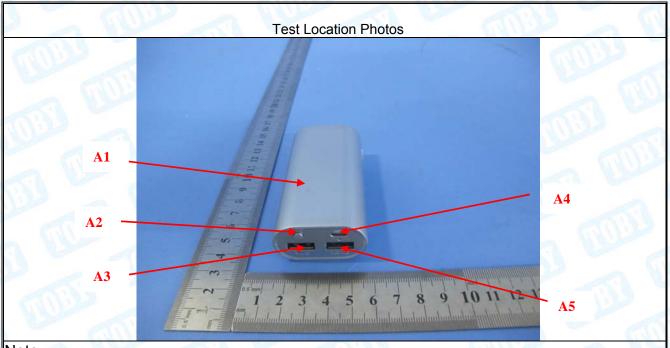
Please refer to the following pages.



## Electrostatic Discharge Test Result

EUT :	Power bank	Model Name :	SP8186
Temperature :	<b>22</b> °C	Humidity :	50%
Power supply :	DC 5V	Test Mode :	Mode 1/2
Test Engineer :	Jason		
Criterion: B			
	$\pm$ 4/ $\pm$ 8kV Contact Disc ive 10 times and negativ		E F
Location	Test Level (kV)	No. of Discharge	Result
A1	Con Con	20	A
A2	±2kV	20	A
A3	±4kV	20	A
	±8kV	20	А
A4		20	
A4 A5		20	A
101	±4kV		1990





#### Note:

- 1) Criteria A: There was no change operated with initial operating during the test.
- 2) Criteria B: The EUT function loss during the test, but self-recoverable after the test.
- 3) Criteria C: The system shut down during the test.



## 6. Radiated Electromagnetic Field Immunity Test

- 6.1. Test Requirements
- 6.1.1. Test Standard

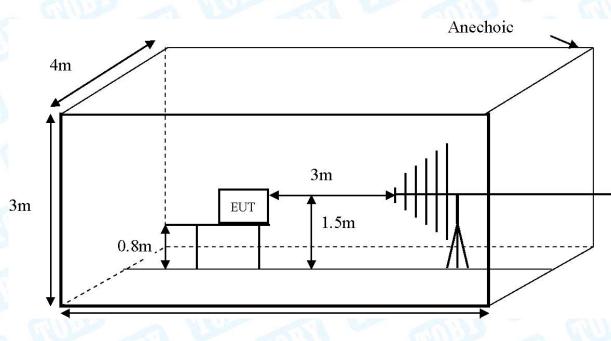
EN 55024:2010+A1: 2015 (EN 61000-4-3:2006+A1:2008+A2:2010)

6.1.2. Test Level

Level	Field Strength V/m
100	
2	3
3	10
X	Special

#### 6.1.3. Performance criterion: A

### 6.2. Test Setup



#### 6.3. Test Procedure

The EUT are placed on a table, which is 0.8 meter high above the ground. The EUT is set 3 meters away from the transmitting antenna, which is mounted on an antenna tower. Both horizontal and vertical polarization of the antenna is set on test. Each of the four sides of the EUT must be faced this transmitting antenna and measured individually.

In order to judge the EUT performance, a camera is used to monitor its screen.

All the scanning conditions are as following:

Condition of Test	Remark3V/m (Severity Level 2)Modulated80-1000MHz		
Fielded strength			
Radiated signal			
Scanning frequency			
Sweep time of radiated	0.0015 Decade/s		
Dwell time	1 Sec.		

### 6.4. Test Data

Please refer to the following pages.



## **RF Field Strength Susceptibility Test Results**

EUT	E Power bank		_ <b>M/N</b>	SP8186	3 Long		
Temperature	: <b>25</b> °C		Humidity	40%	TOBY		
Power supply	: DC 5V		Test Mode	Mode 1/2			
Required Performance Criteria: A							
Modulation: AM	80%						
Pulse: 1 kHz							
A	Actual Performance Criteria						
EUT Position	Frequency Range 1: 80~1000MHz		Frequency Range 2: /		Judgment		
	Horizontal	Vertical	Horizontal	Vertical			
Front	A	A	1		PASS		
Right	A	A	1	700	PASS		
Rear	A	A	1	1	PASS		
Left	A	A	1	1	PASS		
Remark:	-033		GIND				

- 1) Criteria A: There was no change operated with initial operating during the test.
- 2) Criteria B: The EUT function loss during the test, but self-recoverable after the test.
- 3) Criteria C: The system shut down during the test.



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## 7. Photographs - Constructional Details

Photo 1 Appearance of EUT



#### Photo 2 Appearance of EUT





#### Photo 3 Appearance of EUT

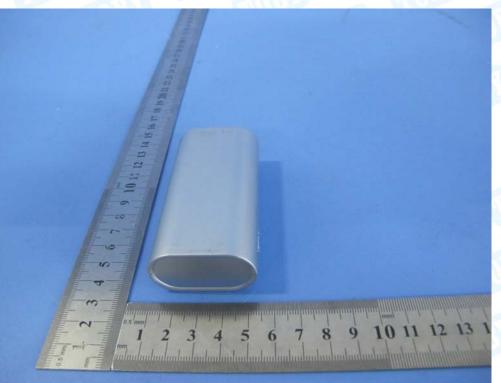
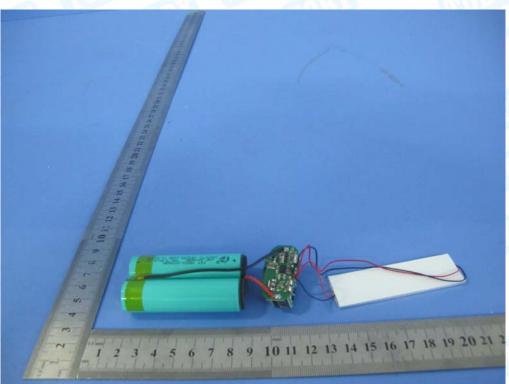
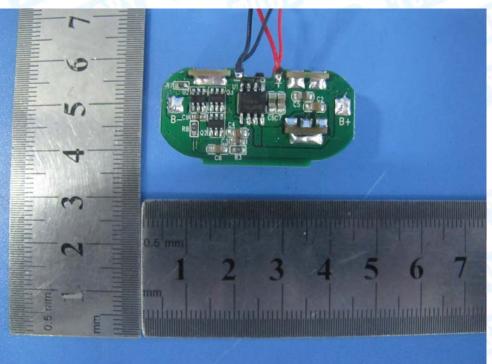


Photo 4 Internal of EUT

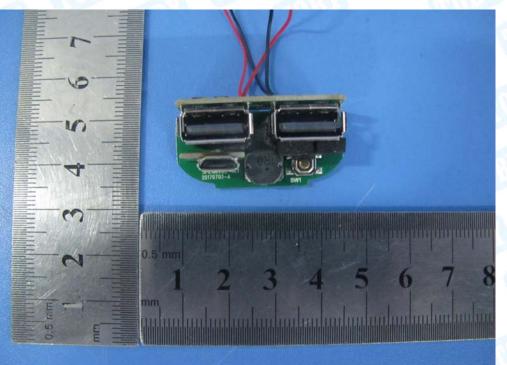




#### Photo 5 Appearance of PCB



#### Photo 6 Appearance of PCB





## 8. Photographs – Test Setup

## Photo 1 Radiated Emission Test Setup



Photo 2 Radiated Emission Test Setup





#### Photo 3 Electrostatic Discharge Test Setup



Photo 4 Electrostatic Discharge Test Setup



----END OF REPORT-----